

1. General description

Planar passivated SCR with sensitive gate in surface mountable SOT23 (TO-236AB) plastic package. This SCR is designed to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

2. Features and benefits

- Sensitive gate (<100 μ A)
- High dv/dt noise immunity
- Planar passivated for voltage ruggedness and reliability
- Miniature SOT23 package for high density PCB
- RoHS compliant, Halogen free and lead free

3. Applications

- Earth leakage circuit breakers or Ground Fault Circuit Interrupters (GFCI)
- Low power latching circuits
- Valve/locker control

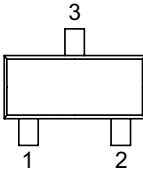

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Values			Unit
V_{DRM}	repetitive peak off-state voltage			600			V
$I_{T(RMS)}$	RMS on-state current	half sine wave; $T_{sp} \leq 108\text{ }^{\circ}\text{C}$; Fig. 1 ; Fig. 2 ; Fig. 3		0.8			A
I_{TSM}	non-repetitive peak on-state current	half sine wave; $T_{j(\text{init})} = 25\text{ }^{\circ}\text{C}$; $t_p = 10\text{ ms}$; Fig. 4 ; Fig. 5		8			A
		half sine wave; $T_{j(\text{init})} = 25\text{ }^{\circ}\text{C}$; $t_p = 8.3\text{ ms}$		9			A
T_j	junction temperature			-40 to 125			$^{\circ}\text{C}$
Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
I_{GT}	gate trigger current	$V_D = 12\text{ V}$; $I_T = 10\text{ mA}$; $T_j = 25\text{ }^{\circ}\text{C}$; Fig. 7		1	-	100	μA
I_H	holding current	$V_D = 12\text{ V}$; $R_{GK} = 1\text{ k}\Omega$; $T_j = 25\text{ }^{\circ}\text{C}$; Fig. 9		-	-	3	mA
V_T	on-state voltage	$I_T = 1.2\text{ A}$; $T_j = 25\text{ }^{\circ}\text{C}$; Fig. 10		-	1.25	1.70	V
Dynamic characteristics							
dV_D/dt	rate of rise of off-state voltage	$V_{DM} = 402\text{ V}$ ($V_{DM} = 67\%$ of V_{DRM}); exponential waveform; $R_{GK} = 1\text{ k}\Omega$; $T_j = 125\text{ }^{\circ}\text{C}$		100	-	-	V/ μs
		$V_{DM} = 200\text{ V}$; exponential waveform; $R_{GK} = 1\text{ k}\Omega$; $T_j = 125\text{ }^{\circ}\text{C}$		200	-	-	V/ μs

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode		
2	G	gate		
3	A	anode		

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
NCR100K-6	SOT23	NCR100K-6X	Reel	3000	SOT23L	22-Aug-2022

7. Marking

Table 4. Marking codes

Type number	Marking codes
NCR100K-6	TA

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V_{DRM}	repetitive peak off-state voltage			600	V
V_{RRM}	repetitive peak reverse voltage			600	V
$I_{T(AV)}$	average on-state current	half sine wave; $T_{sp} \leq 108\text{ °C}$;		0.5	A
$I_{T(RMS)}$	RMS on-state current	half sine wave; $T_{sp} \leq 108\text{ °C}$; Fig. 1 ; Fig. 2 ; Fig. 3		0.8	A
I_{TSM}	non-repetitive peak on-state current	half sine wave; $T_{j(\text{init})} = 25\text{ °C}$; $t_p = 10\text{ ms}$; Fig. 4 ; Fig. 5		8	A
		half sine wave; $T_{j(\text{init})} = 25\text{ °C}$; $t_p = 8.3\text{ ms}$		9	A
I^2t	I^2t for fusing	$t_p = 10\text{ ms}$; sine-wave pulse		0.36	A ² s
di_T/dt	rate of rise of on-state current	$I_G = 200\text{ }\mu\text{A}$		50	A/ μs
I_{GM}	peak gate current			1	A
V_{GM}	peak gate voltage			5	V
V_{GRM}	peak reverse gate voltage			5	V
P_{GM}	peak gate power			2	W
$P_{G(AV)}$	average gate power	over any 20 ms period		0.1	W
T_{stg}	storage temperature			-40 to 150	°C
T_j	junction temperature			-40 to 125	°C

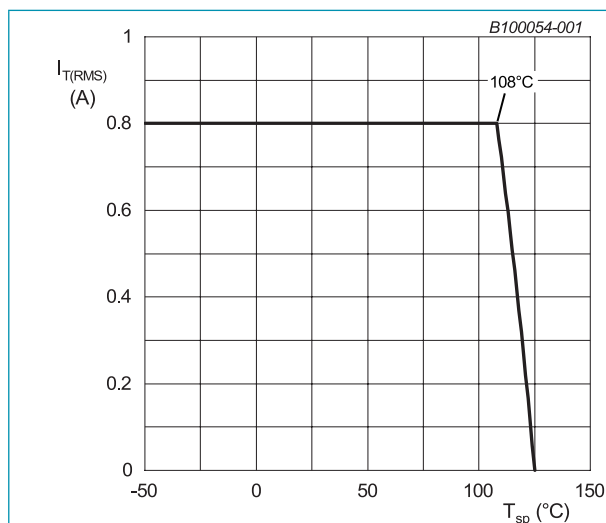


Fig. 1. RMS on-state current as a function of solder point temperature; maximum values

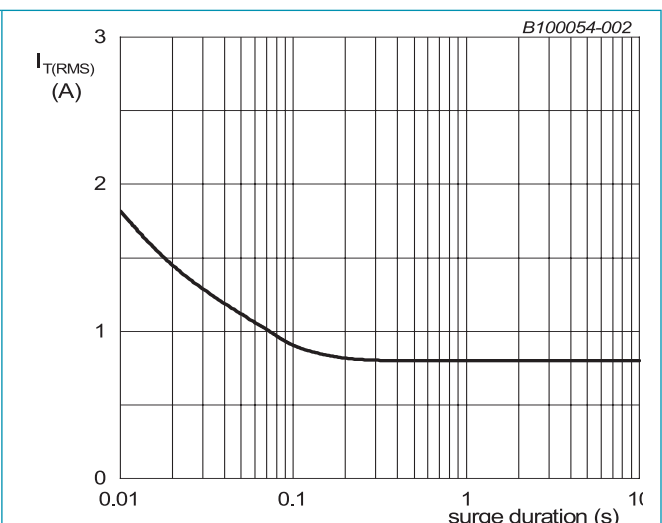
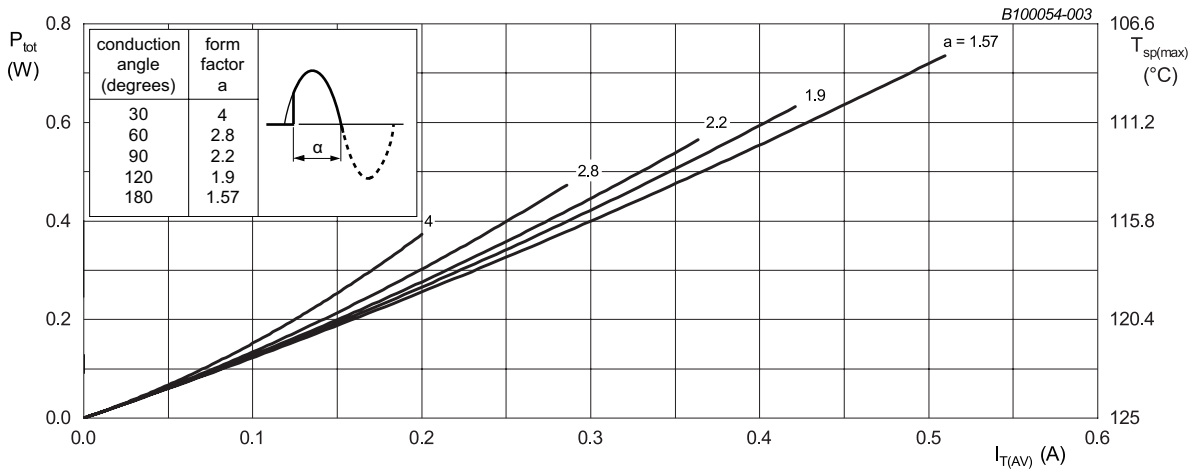
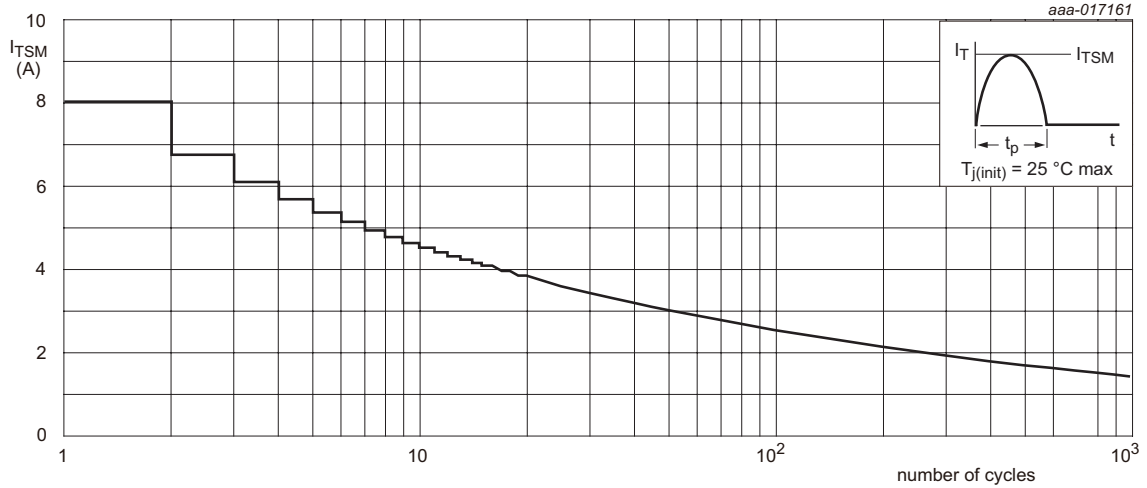


Fig. 2. RMS on-state current as a function of surge duration; maximum values
 $f = 50\text{ Hz}$; $T_{sp} = 108\text{ °C}$



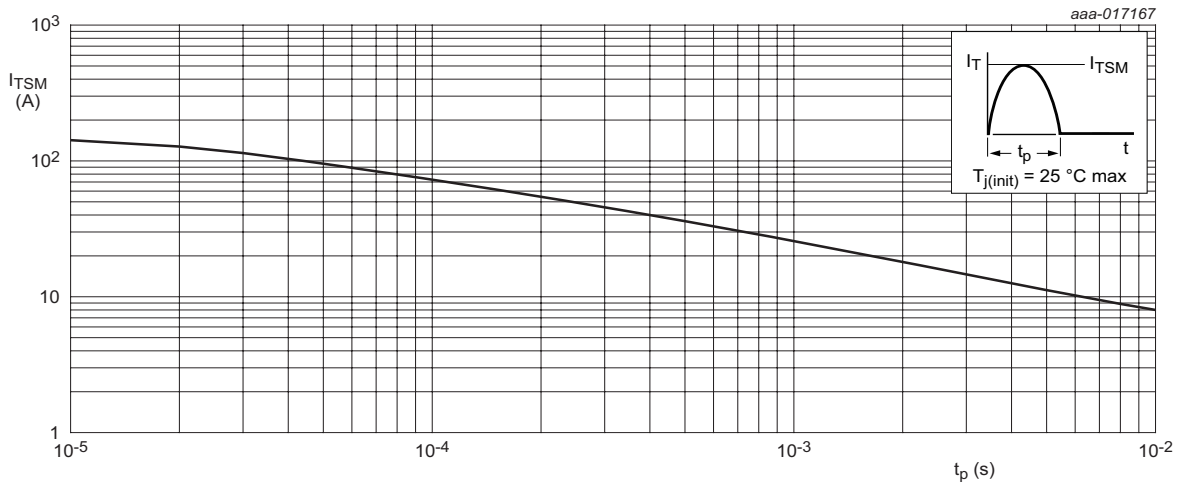
α = conduction angle
 a = form factor = $I_{T(RMS)} / I_{T(AV)}$

Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values



$f = 50 \text{ Hz}$

Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



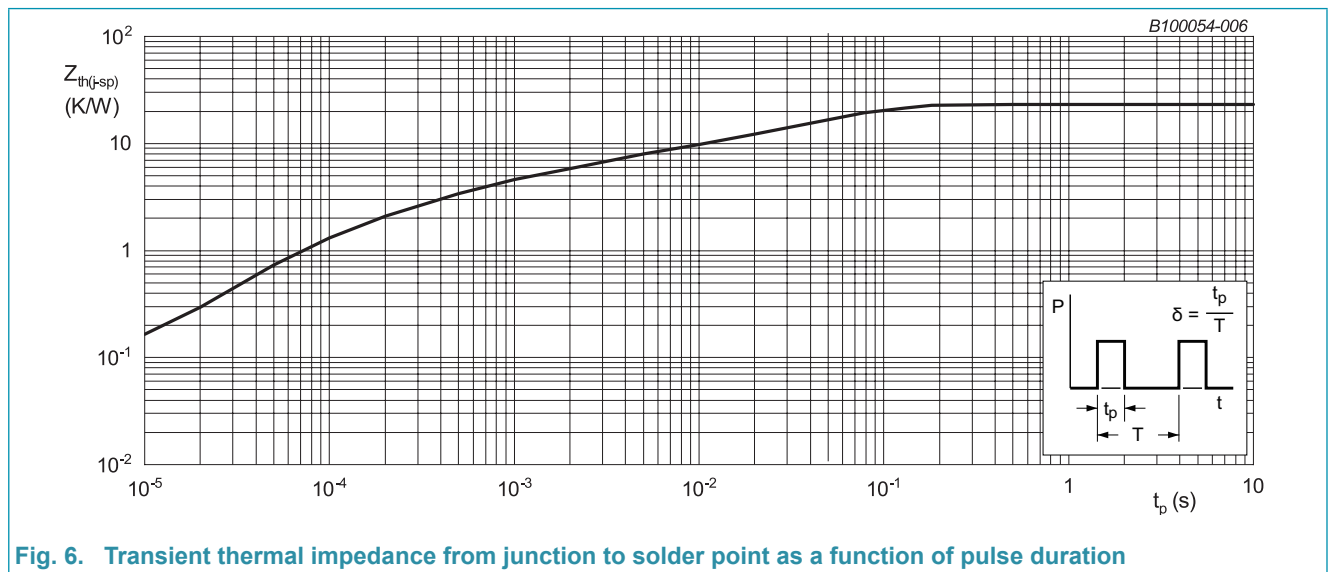
$t_p \leq 10 \text{ ms}$

Fig. 5. Non-repetitive peak on-state current as a function of pulse duration; maximum values

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	Fig. 6		-	-	23	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air		-	105	-	K/W



10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
I_{GT}	gate trigger current	$V_D = 12\text{ V}$; $I_T = 10\text{ mA}$; $T_j = 25\text{ }^\circ\text{C}$; Fig. 7		-	-	100	μA
I_L	latching current	$V_D = 12\text{ V}$; $I_G = 10\text{ mA}$; $R_{GK} = 1\text{ k}\Omega$; $T_j = 25\text{ }^\circ\text{C}$; Fig. 8		-	-	6	mA
I_H	holding current	$V_D = 12\text{ V}$; $R_{GK} = 1\text{ k}\Omega$; $T_j = 25\text{ }^\circ\text{C}$; Fig. 9		-	-	3	mA
V_T	on-state voltage	$I_T = 1.2\text{ A}$; $T_j = 25\text{ }^\circ\text{C}$; Fig. 10		-	1.25	1.70	V
V_{GT}	gate trigger voltage	$V_D = 12\text{ V}$; $I_T = 10\text{ mA}$; $T_j = 25\text{ }^\circ\text{C}$; Fig. 11		-	0.5	0.8	V
		$V_D = 400\text{ V}$; $I_T = 10\text{ mA}$; $T_j = 125\text{ }^\circ\text{C}$		0.3	0.5	-	V
I_D	off-state current	$V_D = 600\text{ V}$; $R_{GK} = 1\text{ k}\Omega$; $T_j = 25\text{ }^\circ\text{C}$		-	-	10	μA
		$V_D = 600\text{ V}$; $R_{GK} = 1\text{ k}\Omega$; $T_j = 125\text{ }^\circ\text{C}$		-	0.05	0.1	mA
I_R	reverse current	$V_D = 600\text{ V}$; $R_{GK} = 1\text{ k}\Omega$; $T_j = 25\text{ }^\circ\text{C}$		-	-	10	μA
		$V_D = 600\text{ V}$; $R_{GK} = 1\text{ k}\Omega$; $T_j = 125\text{ }^\circ\text{C}$		-	0.05	0.1	mA
Dynamic characteristics							
dV_D/dt	rate of rise of off-state voltage	$V_{DM} = 402\text{ V}$ ($V_{DM} = 67\%$ of V_{DRM}); exponential waveform; $R_{GK} = 1\text{ k}\Omega$; $T_j = 125\text{ }^\circ\text{C}$		100	-	-	$\text{V}/\mu\text{s}$
		$V_{DM} = 200\text{ V}$; exponential waveform; $R_{GK} = 1\text{ k}\Omega$; $T_j = 125\text{ }^\circ\text{C}$		200	-	-	$\text{V}/\mu\text{s}$
t_{gt}	gate-controlled turn-on time	$I_{TM} = 0.8\text{ A}$; $V_D = 600\text{ V}$; $I_G = 10\text{ mA}$; $dI_G/dt = 0.1\text{ A}/\mu\text{s}$; $T_j = 25\text{ }^\circ\text{C}$		-	2	-	μs
t_q	commutated turn-off time	$V_{DM} = 402\text{ V}$ ($V_{DM} = 67\%$ of V_{DRM}); $I_{TM} = 0.8\text{ A}$; $V_R = 35\text{ V}$; $(dI_T/dt)_M = 30\text{ A}/\mu\text{s}$; $dV_D/dt = 2\text{ V}/\mu\text{s}$; $R_{GK} = 1\text{ k}\Omega$; $T_j = 125\text{ }^\circ\text{C}$		-	100	-	μs

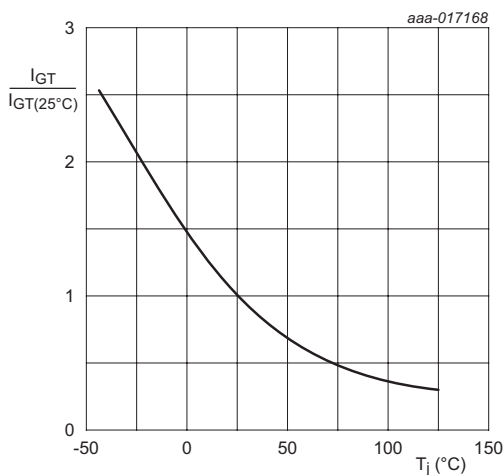


Fig. 7. Normalized gate trigger current as a function of junction temperature

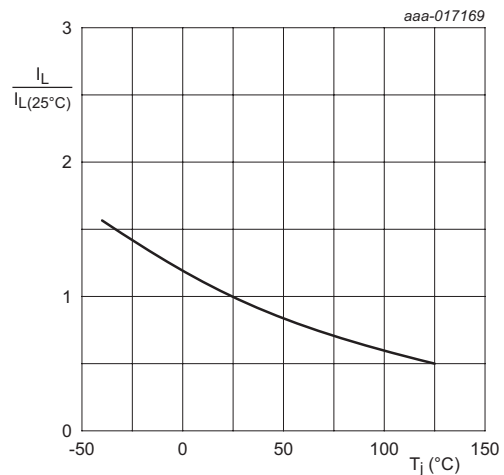


Fig. 8. Normalized latching current as a function of junction temperature

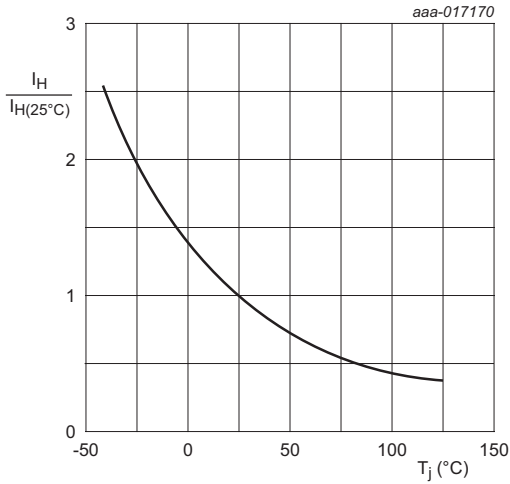
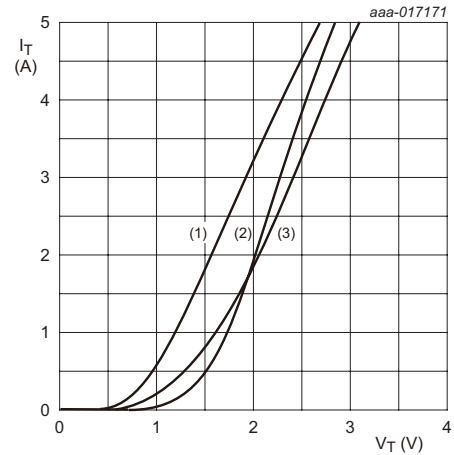


Fig. 9. Normalized holding current as a function of junction temperature



$V_o = 1.173 \text{ V}$; $R_s = 0.2156 \Omega$
 (1) $T_j = 125^\circ\text{C}$; typical values
 (2) $T_j = 25^\circ\text{C}$; maximum values
 (3) $T_j = 125^\circ\text{C}$; maximum values

Fig. 10. On-state current as a function of on-state voltage

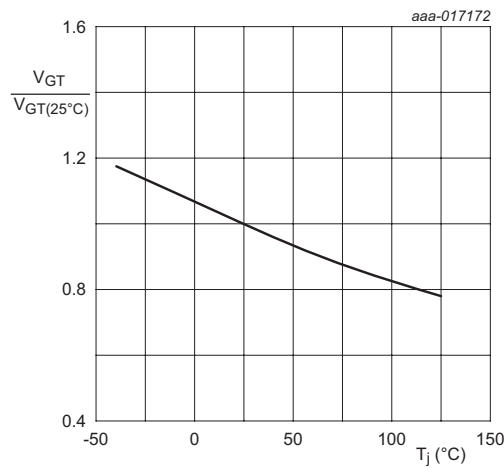
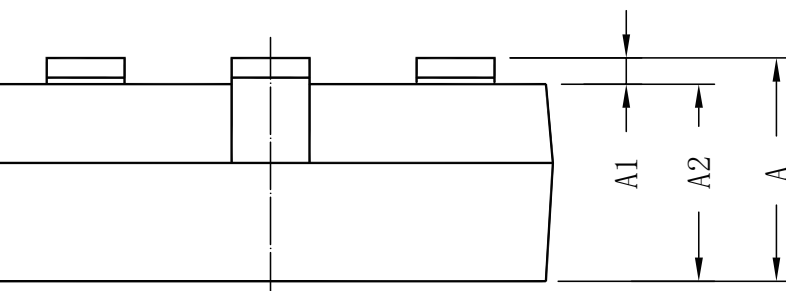
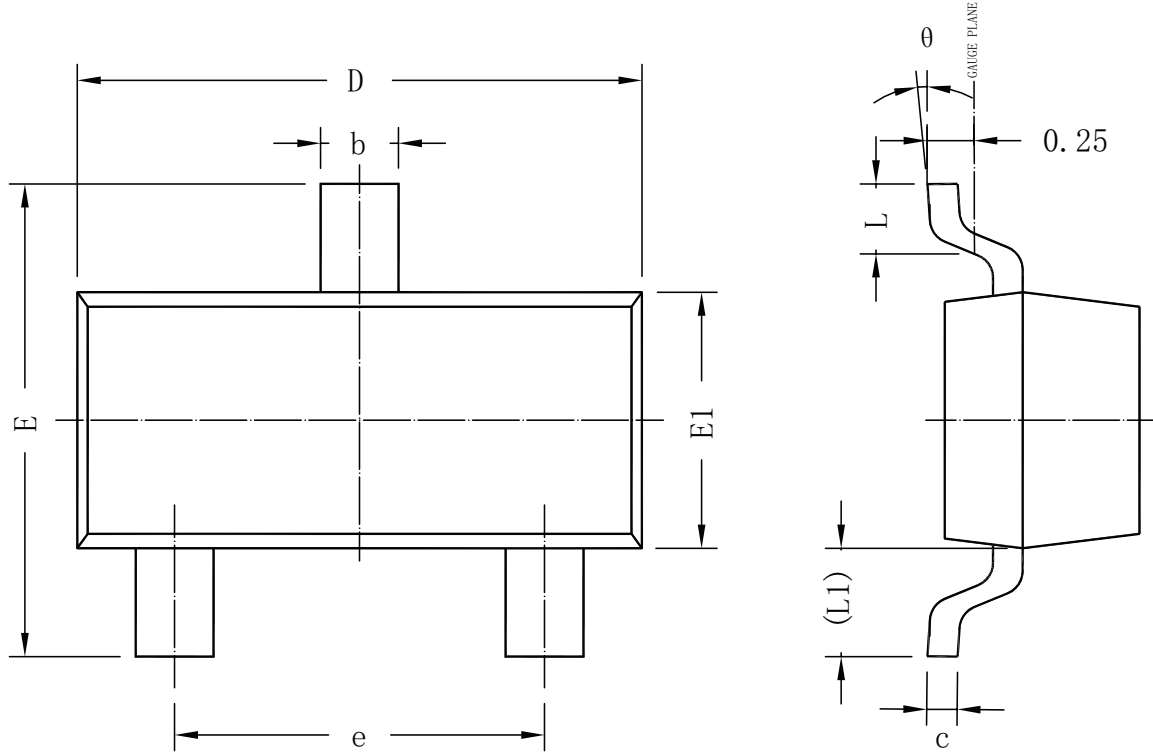


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

11. Package outline



UNIT	A	A1	A2	b	c	D	E	E1	e	L	L1	θ
mm	Min	0.90	0.00	0.90	0.30	2.80	2.25	1.20	1.80	0.30	(0.55)	0°
	Max	1.20	0.10	1.10	0.50	3.00	2.55	1.40	2.00	0.50		8°

Note:

- All dimensions don't include mold flash and metal protrusion.

12. Legal information

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Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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13. Contents

- 1. General description..... 1
- 2. Features and benefits 1
- 3. Applications 1
- 4. Quick reference data 1
- 5. Pinning information..... 2
- 6. Ordering information..... 2
- 7. Marking..... 2
- 8. Limiting values 3
- 9. Thermal characteristics 5
- 10. Characteristics..... 6
- 11. Package outline 8
- 12. Legal information 9
- 13. Contents 11

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